

**Search Notes**

Application/Control No.

10/714,207

Examiner

Michael Trinh

Applicant(s)/Patent under  
Reexamination

CHIU ET AL.

Art Unit

2822

**SEARCHED**

Class	Subclass	Date	Examiner
438	Updated previous subclasses	9/27/2006	MT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR